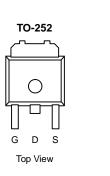
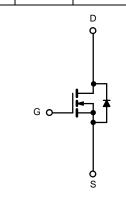


05N03LB-VB Datasheet N-Channel 30-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | |
|---------------------|----------------------------------|------------------------------------|----------------------|--|--|
| V _{DS} (V) | R _{DS(on)} (Ω) | I _D (A) ^{a, e} | Q _g (Typ) | | |
| 30 | 0.002 at V _{GS} = 10 V | 100 | 72 nC | | |
| - 50 | 0.003 at V _{GS} = 4.5 V | 90 | 72110 | | |





N-Channel MOSFET

FEATURES

- ٠ Trench Power MOSFET
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2011/65/EU ٠

APPLICATIONS

- OR-ing
- Server
- DC/DC

| Parameter | | Symbol | Limit | Unit | |
|--|------------------------|-----------------------------------|----------------------|------|--|
| Drain-Source Voltage | V _{DS} | 30 | V | | |
| Gate-Source Voltage | | V _{GS} | ± 20 | v | |
| | T _C = 25 °C | | 100 ^{a, e} | A | |
| Continuous Drain Current (T _J = 175 °C) | T _C = 70 °C | | 80 ^e | | |
| $Continuous Drain Current (1_j = 175 C)$ | T _A = 25 °C | I _D | 35.8 ^{b, c} | | |
| | T _A = 70 °C | | 27 ^{b, c} | | |
| Pulsed Drain Current | I _{DM} | 300 | _ | | |
| Avalanche Current Pulse | L = 0.1 mH | I _{AS} | 39 | | |
| Single Pulse Avalanche Energy | L = 0.1 mm | E _{AS} | 94.8 | mJ | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | | 90 ^{a, e} | A | |
| Continuous Source-Drain Diode Current | T _A = 25 °C | I _S | 3.13 ^{b, c} | | |
| | T _C = 25 °C | | 235 ^a | | |
| Mauiauna Daura Diasia stian | T _C = 70 °C | P | 165 | | |
| Maximum Power Dissipation | T _A = 25 °C | P _D | 3.75 ^{b, c} | W | |
| | T _A = 70 °C | | 2.63 ^{b, c} | | |
| Operating Junction and Storage Temperature Ra | ange | T _J , T _{stg} | - 55 to 175 | °C | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|------------------------|-------------------|------|------|------|--|
| Parameter | | Symbol | Тур. | Max. | Unit | |
| Maximum Junction-to-Ambient ^{b, d} | $t \le 10 \text{ sec}$ | R _{thJA} | 32 | 40 | °C/W | |
| Maximum Junction-to-Case | Steady State | R _{thJC} | 0.5 | 0.6 | 0/10 | |

Notes:

a. Based on $T_C = 25 \text{ °C}$. b. Surface mounted on 1" x 1" FR4 board.

a. t = 10 sec.
d. Maximum under steady state conditions is 90 °C/W.
e. Calculated based on maximum junction temperature. Package limitation current is 90 A.



| | SPECIFICATIONS (T _J = 25 °C, | | | | - | _ _ | |
|---|--|---------------------|--|-------|-------|------------|------|
| $\begin{array}{c c c c c c c c c c c c c c c c c c c $ | | Symbol | Test Conditions | Min. | Тур. | Max. | Unit |
| $ \begin{array}{ c c c c c c c c c c c c c c c c c c c$ | | V | V 0.V 1 250 ··· 4 | | | 1 | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | 6 | | $v_{GS} = 0 v, I_D = 250 \mu A$ | 30 | 0.5 | | V |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | | | I _D = 250 μA | | | | mV/° |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | | . , | | | - 7.5 | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | 5 | | | 1.5 | | 2.5 | V |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Gate-Source Leakage | I _{GSS} | | | | ± 100 | nA |
| $ \begin{array}{ c c c c c c c c c c c c c c c c c c c$ | Zero Gate Voltage Drain Current | loss | 50 00 | | | 1 | μA |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | | -033 | | | | 10 | |
| $\begin{array}{ c c c c c c c c c c c c c c c c c c c$ | On-State Drain Current ^a | I _{D(on)} | | 90 | | | Α |
| $ \begin{array}{ c c c c c } \hline V_{GS} = 4.5 \ V, \ v_{DS} = 37 \ A \\ \hline 0.003 $ | Drain Source On State Desistence | Base | V _{GS} = 10 V, I _D = 38.8 A | 0.002 | | | 0 |
| | Drain-Source On-State Resistance- | ''DS(on) | $V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 37 \text{ A}$ | | 0.003 | | 52 |
| $ \begin{array}{ c c c c c c c } \hline Input Capacitance & C_{IBS} \\ \hline Output Capacitance & C_{GSS} \\ \hline Output Capacitance & C_{rss} \\ \hline Output Cap$ | Forward Transconductance ^a | 9 _{fs} | V _{DS} = 15 V, I _D = 38.8 A | | 160 | | S |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Dynamic ^b | | | | | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Input Capacitance | C _{iss} | | | 5201 | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Output Capacitance | C _{oss} | V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz | | 1525 | | pF |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Reverse Transfer Capacitance | C _{rss} | | | 770 | | |
| $ \begin{array}{ c c c c c c } \hline \begin{tabular}{ c c c c c } \hline \begin{tabular}{ c c c c c c } \hline \begin{tabular}{ c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$ | Tatal Oats Observe | 0 | $V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 38.8 \text{ A}$ | | 151 | 227 | 3 |
| $ \begin{array}{ c c c c c } \hline Gate-Source Charge & $ $ $ $ $ $ $ $ $ $ $ $ $ $ $ $ $ $ $ | Total Gate Charge | Qg | | | 71.5 | 103 | |
| $ \begin{array}{c c c c c c c c c c } \hline Gate Resistance & R_g & f = 1 \ MHz & 1.4 & 2.1 & \Omega \\ \hline Turn-On Delay Time & t_d(on) & & & & & & & & & & & & & & & & & & &$ | Gate-Source Charge | Q _{gs} | V_{DS} = 15 V, V_{GS} = 4.5 V, I_{D} = 28.8 A | | 30 | | |
| $ \begin{array}{c c c c c c c c c c } \hline Turn-On Delay Time & t_{d(on)} \\ \hline Rise Time & t_r & V_{DD} = 15 \ V, \ R_L = 0.625 \ \Omega & 11 & 17 \\ \hline I_D \equiv 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 70 & 105 \\ \hline I_D \equiv 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 70 & 105 \\ \hline I_D \equiv 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 70 & 105 \\ \hline Turn-On Delay Time & t_f & 10 & 15 \\ \hline Turn-On Delay Time & t_r & V_{DD} = 15 \ V, \ R_L = 0.67 \ \Omega & 180 & 270 \\ \hline I_D \equiv 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 55 & 83 \\ \hline Fall Time & t_f & 12 & 18 \\ \hline \hline Drain-Source Body Diode Characteristics & & & & & \\ \hline Drain-Source Body Diode Characteristics & & & & & & & & \\ \hline Continuous Source-Drain Diode Current & I_S & T_C = 25 \ C & & & & & & & & & & & & \\ \hline Pulse Diode Forward Current^a & I_{SM} & & & & & & & & & & & & \\ \hline Body Diode Reverse Recovery Time & t_r & & & & & & & & & & & & & \\ \hline Body Diode Reverse Recovery Charge & Q_{rr} & & & & & & & & & & & & & \\ \hline Reverse Recovery Fall Time & t_a & & & & & & & & & & & & & & & \\ \hline \end{array}$ | Gate-Drain Charge | Q _{gd} | | | 24 | | |
| $\begin{array}{ c c c c c } \hline Rise Time & t_r & V_{DD} = 15 \ V, \ R_L = 0.625 \ \Omega & 11 & 17 \\ \hline I_D \cong 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 22 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 22 \ S \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 55 & 83 \\ \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 55 & 83 \\ \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 12 \\ \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 12 \\ \hline \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline \hline \hline \hline I_D \cong Diode \ Forward \ Current^a \ I_S \$ | Gate Resistance | R _g | f = 1 MHz | | 1.4 | 2.1 | Ω |
| $\begin{array}{ c c c c c } \hline Rise Time & t_r & V_{DD} = 15 \ V, \ R_L = 0.625 \ \Omega & 11 & 17 \\ \hline I_D \cong 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 24 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 22 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 15 \\ \hline I_D \cong 22 \ S \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 55 & 83 \\ \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 55 & 83 \\ \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 12 \\ \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 12 \\ \hline \hline \hline \hline I_D \cong 22.5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 12 & 18 \\ \hline \hline \hline \hline \hline \hline I_D \cong Diode \ Forward \ Current^a \ I_S \$ | Turn-On Delay Time | t _{d(on)} | | | 18 | 27 | |
| $ \begin{array}{c c c c c c c c c c c c } \hline Turn-Off Delay Time & t_{d(off)} & I_D \cong 24 \text{ A}, \ V_{GEN} = 10 \text{ V}, \ R_g = 1 \Omega & 70 & 105 \\ \hline Turn-On Delay Time & t_{d(on)} & & & & & & & & & & & & & & & & & & &$ | Rise Time | | $V_{DD} = 15 \text{ V}, \text{ R}_{1} = 0.625 \Omega$ | | 11 | 17 | - |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Turn-Off Delay Time | t _{d(off)} | $I_D \cong 24 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$ | | 70 | 105 | |
| $\begin{array}{c c c c c c c c c c c c c c c c c c c $ | Fall Time | . , | | | 10 | 15 | |
| $\begin{array}{c c c c c c c c c c c c c c c c c c c $ | Turn-On Delay Time | t _{d(on)} | | | 55 | 83 | ns |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Rise Time | | V _{DD} = 15 V, R _I = 0.67 Ω | | 180 | 270 | |
| Fall Time t_f 1218Drain-Source Body Diode Characteristics t_f 1218Drain-Source Body Diode Characteristics $T_C = 25 ^{\circ}C$ 120 A Continuous Source-Drain Diode Current I_S $T_C = 25 ^{\circ}C$ 120 A Pulse Diode Forward Current ^a I_{SM} 120 A Body Diode Voltage V_{SD} $I_S = 22 ^{A}$ 0.8 1.2 V Body Diode Reverse Recovery Time t_{rr} $F_r = 20 ^{A}$, di/dt = 100 A/\mus , $T_J = 25 ^{\circ}C$ 70.2 105 nC Reverse Recovery Fall Time t_a T_a 27 ns ns | Turn-Off Delay Time | | | | 55 | 83 | - |
| Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode CurrentIs $T_C = 25 \text{ °C}$ 120Pulse Diode Forward Current ^a IsM120ABody Diode Voltage V_{SD} $I_S = 22 \text{ A}$ 0.81.2VBody Diode Reverse Recovery Time t_{rr} 52 78nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = 20 \text{ A}$, di/dt = 100 A/µs, $T_J = 25 \text{ °C}$ 70.2105nCReverse Recovery Fall Time t_a T_a T_{rr} T_{rr} T_{rr} T_{rr} | | | - 9 | | | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Drain-Source Body Diode Characteristic | | | | I | | |
| Pulse Diode Forward Current ^a Ism120ABody Diode Voltage V_{SD} $I_S = 22 \text{ A}$ 0.81.2VBody Diode Reverse Recovery Time t_{rr} 5278nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = 20 \text{ A}$, di/dt = 100 A/µs, $T_J = 25 \text{ °C}$ 70.2105nCReverse Recovery Fall Time t_a t_a 27 ns | Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | | | 120 | |
| Body Diode Voltage V_{SD} $I_S = 22 \text{ A}$ 0.81.2VBody Diode Reverse Recovery Time t_{rr} 5278nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = 20 \text{ A}, di/dt = 100 \text{ A/µs}, T_J = 25 °C$ 70.2105nCReverse Recovery Fall Time t_a r_a r_a r_a r_a r_a r_a | Pulse Diode Forward Current ^a | | | | 1 | 120 | A |
| Body Diode Reverse Recovery Time t_{rr} 5278nsBody Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a | | | I _S = 22 A | | 0.8 | | V |
| Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a | , 0 | | - | | | | ns |
| Reverse Recovery Fall Time t_a $I_F = 20 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}, I_J = 25 \text{ °C}$ 27 ns | | | | | | | |
| ns ns | | | $I_F = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$ | - | | | |
| | Reverse Recovery Rise Time | t _b | | | 25 | | ns |

Notes:

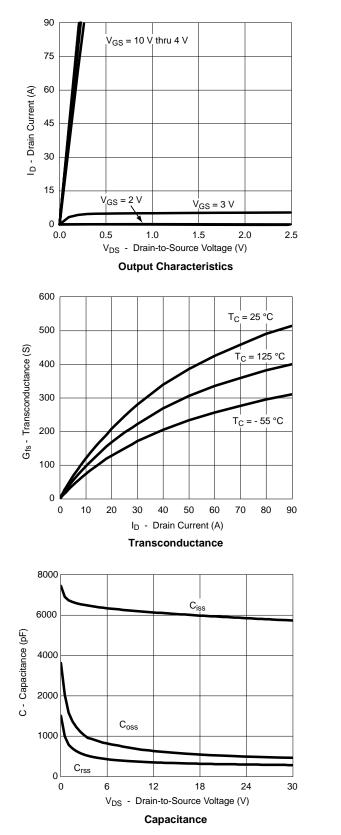
a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

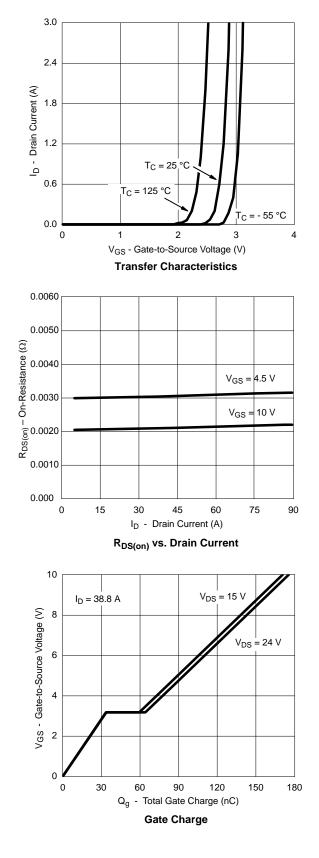
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Bsemi



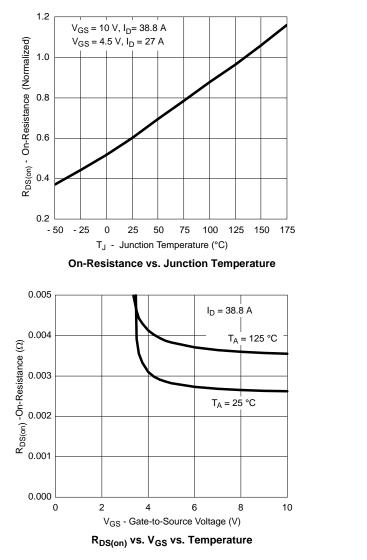


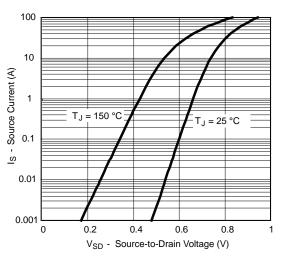
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



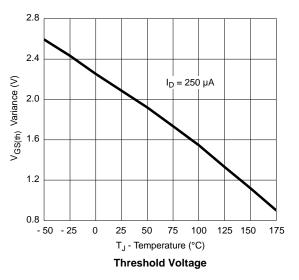


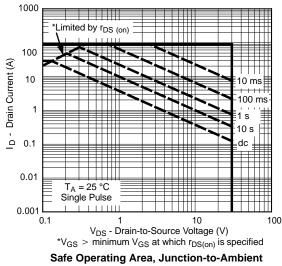




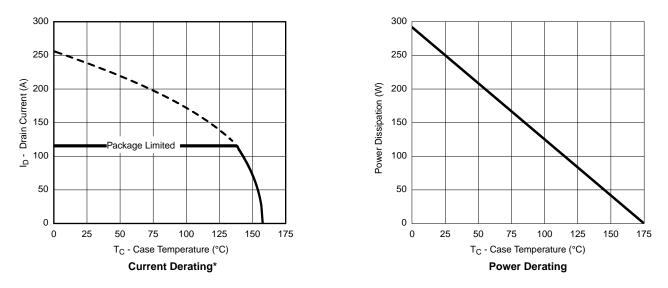


Forward Diode Voltage vs. Temperature









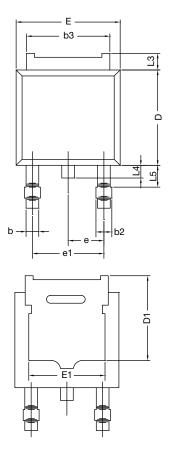
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

*The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





TO-252AA CASE OUTLINE





| | MILLIN | IETERS | INC | HES | |
|-----------------------|-------------------|-----------|-----------|-------|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | |
| А | 2.18 | 2.38 | 0.086 | 0.094 | |
| A1 | - | 0.127 | - | 0.005 | |
| b | 0.64 | 0.88 | 0.025 | 0.035 | |
| b2 | 0.76 | 1.14 | 0.030 | 0.045 | |
| b3 | 4.95 | 5.46 | 0.195 | 0.215 | |
| С | 0.46 | 0.61 | 0.018 | 0.024 | |
| C2 | 0.46 | 0.89 | 0.018 | 0.035 | |
| D | 5.97 | 6.22 | 0.235 | 0.245 | |
| D1 | 5.21 | - | 0.205 | - | |
| Е | 6.35 | 6.73 | 0.250 | 0.265 | |
| E1 | 4.32 | - | 0.170 | - | |
| Н | 9.40 | 10.41 | 0.370 | 0.410 | |
| е | 2.28 | BSC | 0.090 BSC | | |
| e1 | 4.56 | BSC | 0.180 BSC | | |
| L | 1.40 | 1.78 | 0.055 | 0.070 | |
| L3 | 0.89 | 1.27 | 0.035 | 0.050 | |
| L4 | - | 1.02 | - | 0.040 | |
| L5 | 1.14 | 1.52 | 0.045 | 0.060 | |
| ECN: X12- DWG: 534 | 0247-Rev. M, 7 | 24-Dec-12 | | | |

Note

• Dimension L3 is for reference only.



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